

PROGRAMMABLE CURRENT REGULATOR

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Abstract. A flexible circuit of programmable current regulator suitable for computer-controlled equipments is proposed. Its output current changes in steps ΔI_0 can be also programmable. Both theoretical analysis and practical circuit are included.

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The current regulators are used in many physical experiments. When computer-controlled measurement and testing has to be done, it is necessary to use programmable regulators. Such type of circuits are given in [1-4]. The output current I_0 changes with fixed step value ΔI_0 . Some more complicated circuits are considered in [5].

Here a new flexible circuit is proposed, and ΔI_0 can be programmed or adjusted. The circuit description with basic equations and DC analysis is given. By the use of different resistive matrices a great number of practical circuits can be realised. To prove the theory an experimental circuit was realised and tested.

1. Basic Circuit

The basic circuit is given in Fig.1. The SM is a two-port resistive matrix with a transmission gain $K_{SM} = U^+ / U_R$ and VM is one-port resistive matrix with resistance R_{VM} . By simple analysis with ideal OAs the expression for the output voltage of OA2 is obtained as follows:

$$U_2 = \frac{R_2}{R_3} \left(1 + \frac{R_1}{R_{VM}} + \frac{R_1}{R_2} \right) K_{SM} U_R + \frac{R_1 R_4}{R_2 R_3} U_L. \quad (1a)$$

According to Fig. 1 the output current is $I_0(U_2 - U_L) / R_I$ and using Eq. (1a) the formula

$$I_0 = \frac{1}{R_I} \left[\frac{R_4}{R_3} \left(1 + \frac{R_1}{R_{VM}} + \frac{R_1}{R_2} \right) K_{SM} U_R + \left(\frac{R_1 R_4}{R_2 R_3} - 1 \right) U_L \right] \quad (1b)$$

is obtained. It can be seen that when the condition

$$R_1 R_4 = R_2 R_3 \quad (2a)$$

is satisfied, the output current

$$I_0 = \frac{U_R}{R_I} \left(1 + \frac{R_4}{R_3} + \frac{R_2}{R_{VM}} \right) K_{SM} \quad (2b)$$

is independent from the voltage U_L and the load R_L . So under the condition (2a) the circuit is an ideal current regulator. For negative voltage U_R the output current goes out from the circuit and it is a current source. With $U_R > 0$ the current I_0 enters and the regulator acts as a current sink.

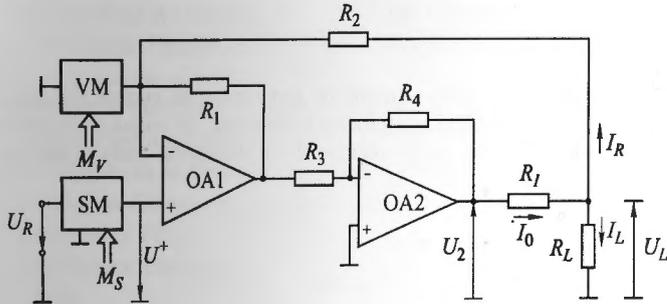


Fig. 1. Basic circuit

Really Eq. (2a) is never true (due to the tolerances of the resistors $R_1 - R_4$) and can be written as $R_1 R_4 = a R_2 R_3$, where $a \neq 1$. So the output resistance of the real current regulator is

$$R_0 = \frac{R_I + R_{O2}}{1 - a} \quad (3)$$

where $R_{O2} = \frac{R_{O(OA2)}}{1 + \frac{R_6 R_{O2}}{R_5 + R_6}}$ and $R_{O(OA2)}$ and A_{O2} are the output resistance and the

DC gain of the OA2 respectively. The real output current depends on the load R_L according to the equation

$$I_{0r(L)} = \frac{I_0}{1 + \frac{R_0}{R_L}} \quad (4)$$

Supposing $R_1 - R_4$ with equal tolerances δ_R for the worst case (R_1 and R_4 are with tolerance $+\delta_R$ and R_2 and R_3 with tolerance $-\delta_R$) the coefficient $a = (1 - \delta_R)^2 / (1 + \delta_R)^2$. To obtain a great R_0 and a real current $I_{0r(L)}$ close to I_0 , resistors with small tolerances ($\delta_R \leq 1\%$) have to be used. In this case $1 - a \approx 4\delta_R$, which permits an easy calculation of R_0 and $I_{0r(L)}$.

The parameter line regulation of the circuit is defined as $LR = (\Delta I_0 / I_0) / (\Delta U_C / U_C)$, where $\Delta I_0 / I_0$ is the relative change of I_0 due to the relative change $\Delta U_C / U_C$ of both supply voltages of OA2. Using the parameters power

supply rejection ratio $PSRR_1$ of OA1 and $PSRR_2$ of OA2 with simple analysis of the circuit the expression

$$LR = \frac{BU_C}{\left(1 + \frac{R_L}{R_I}\right) I_0} \quad (5a)$$

is obtained. In Eq. (5a) the coefficient B is

$$B = \frac{R_4}{R_3} \left[1 + \frac{R_1}{R_{VM} || (R_2 + R_0)} \right] \times 10^{-0.05PSRR_1} + \left(1 + \frac{R_4}{R_3} \right) \times 10^{-0.05PSRR_2} \quad (5b)$$

and I_0 is given by Eq. (2b). Obviously LR changes during the programming of I_0 .

The offset voltage U_{IO} , the bias current I_{IB} and the offset current I_{IO} of both OAs have influence on the output current, creating its component $I_{O(R)}$. According to the explanations in [6] these three parameters give the component

$$U_{O(B1)} = \frac{U_{IO(1)} + (R_{0(SM)} - R_{1(-)}) I_{IB(1)} + R_{1(-)} I_{IO(1)}}{1 + \frac{R_2}{R_{VM}} + \frac{R_2}{R_1}} \quad (6a)$$

in the output voltage of OA1, where $R_{0(SM)}$ is the output resistance of SM and $R_{1(-)} = R_1 || R_2 || R_{VM}$. In the voltage U_2 there is a component

$$U_{2(B2)} = -\frac{R_4}{R_3} U_{O(B1)} + \left(1 + \frac{R_4}{R_3} \right) \left[U_{IO(2)} - \frac{R_3 R_4}{R_3 + R_4} (I_{IB(2)} - I_{IO(2)}) \right] \quad (6b)$$

So to I_{0r} is added

$$I_{0(B)} = \frac{U_{O(B2)}}{R_I} \quad (6c)$$

It is recommended to choose both OAs so that $I_{0(B)} \leq 0.5\Delta I_0$.

From Fig. 1 can be seen that $I_0 = I_L + I_R$ and $I_R = (U_L + U^+) / R_3$. When the load R_I varies, the voltage U_L and the current I_R change too.

These changes cause an error in the load current I_L (the circuit maintains constant the value of I_0). The error is maximal for U_{Lmax} (which can be supposed for instant equal to the maximal output voltage U_{2max} of OA2) and $K_{SM} = 1$ or $U^+ = U_R$. With the choice of

$$R_3 \geq \frac{U_{2max} + |U_R|}{k\Delta I_0} \quad (7)$$

the difference $I_L - I_0$, i. e. the error due to R_3 is smaller than that of $k\Delta I_0$. The coefficient k must be chosen too.

2. Practical Considerations

The step matrix SM can be any digital-to-analog converter (DAC) with voltage output. In this case

$$K_{SM} = \frac{m_S}{2^{n_S}}, \quad R_{i(SM)} = R_{SM} \quad (8a)$$

where m_S is the decimal number corresponding to the step word M_S , and n_S and R_{SM} are the resolution and the resistance of the DAC respectively. Ordinary the output resistance is $R_{0(SM)} \approx 0$. So the output current is

$$I_0 = m_S \Delta I_0 \quad (8b)$$

where

$$\Delta I_0 = \frac{U_R}{2^{n_S} R_I} \left(1 + \frac{R_4}{R_3} + \frac{R_2}{R_{VM}} \right) \quad (8c)$$

The value of I_0 can be programmed by M_S from 0 (with $m_S = 0$) to $I_{0\max} = -(2^{n_S} - 1) \Delta I_0$ in 2^{n_S} steps ΔI_0 .

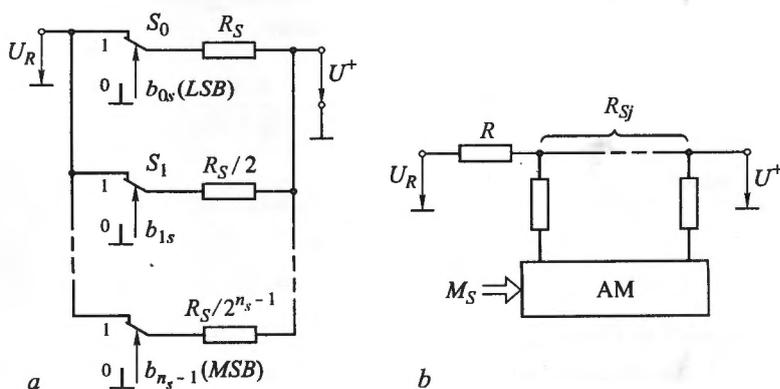


Fig. 2. Resistive matrices for SM
(a) weight matrix; (b) matrix for arbitrary values

For smaller number of steps (i. e. below 100) different types of resistive matrices as SM can be used. The weight matrix in Fig. 2a [7] uses n analog switches S_i . Each of them is controlled by one bit b_i of M_S and is in position "1" for $b_i = 1$. The step word is $M_S = b_{n-1} \dots b_1 b_0$ and the matrix parameters are

$$K_{SM} = \frac{m_S}{N_{m_S}}, \quad R_{i(SM)} = \frac{R_S}{m_S} \left(1 - \frac{m_S}{N_{m_S}} \right), \quad R_{0(SM)} = \frac{R_S}{N_{m_S}} \quad (9a)$$

where $N_{m_S} = 2^{n_S - 1}$ and $R_{i(SM)}$ is the input resistance. The output current is given by Eq. (8b) with

$$\Delta I_0 = \frac{U_R}{N_{m_S} R_I} \left(1 + \frac{R_4}{R_3} + \frac{R_2}{R_{VM}} \right). \quad (9b)$$

The number of steps of I_0 is 2^{n_S} with first step ($m_S = 0$ or all S_i in position "0") $I_0 = 0$. A variant of this matrix with four analog switches and resistance $R_S/2$ in a series with S_3 ensures $N_{m_S} = 9$. It is suitable for digital instruments.

For arbitrary values of I_0 the circuit from Fig. 2b is recommended as SM. Its transmission gain in the j -th position of the analog multiplexer AM is $K_{Sj} = R_{Sj} / (R + R_{Sj})$, which must be submitted in Eq. (2b) to obtain the value I_{0j} of the output current.

It is possible to use as SM the digital potentiometers [8, 9] or digital attenuators [10], provided by different firms.

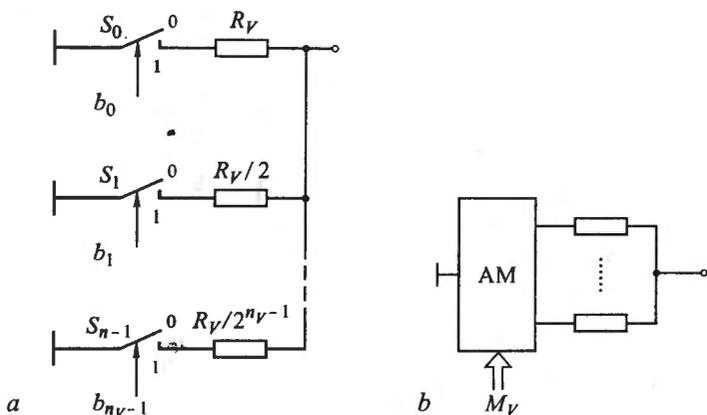


Fig. 3. Resistive matrices for VM
(a) weight matrix; (b) matrix for arbitrary values

The step value ΔI_0 can be programmed according to Eqs (8c) and (9b) through the value matrix VM. A suitable choice for VM is the matrix in Fig. 3a. Its resistance $R_{VM} = R_V/m_V$ is controlled by the value word $M_V = b_{n-1} \dots b_1 b_0$ to which corresponds the decimal number m_V . So the step ΔI_0 is directly proportional to m_V . For arbitrary steps the circuit in Fig. 3b must be used. In the j -th position of the AM the resistance is $R_{VM} R_{Vj}$.

The choice of the OA2 depends on the maximal output current I_{0max} of the regulator. It is the recommended power OAs or audio power amplifiers. For $U_L > 20$ V must be used high-voltage OAs. The power dissipated on OA2 is

$$P_{D2} = U_{C2} I_0 - (R_I + R_L) I_0^2 \quad (10a)$$

where U_{C2} is the supply voltage of OA2. The value of P_{D2} depends on R_L and is

maximal for $R_L = 0$. In this case the inequalities

$$U_{C2} \leq 2I_{OA2\max}R_I \text{ and } U_{C2} \leq 2\sqrt{P_{OA2\max}R_I} \quad (10b)$$

must be satisfied, where $I_{OA2\max}$ and $P_{OA2\max}$ are the maximal output current and power of OA2.

A special attention should be paid to the resistor R_I . Its power dissipation is $I_0^2 R_I$ and can attain values up to 10 W or more. A tolerance not great than 0.1 % is recommended to obtain a sufficiently exact value of I_0 .

The load resistance R_L vary between 0 and

$$R_{L\max} = \frac{U_{2\max}}{I_0} - R_I \quad (11)$$

where $U_{2\max}$ depends on O_{A2} and U_{C2} .

3. Simplified Circuits

When the programming of ΔI_0 is not necessary, then the VM can be eliminated, which means $R_{VM} \rightarrow \infty$ in Eq. (1b), (2b), (8c) and (9b).

For $\Delta I_0 = \text{const}$ and necessary adjustment of I_0 the matrix VM is replaced by a series connection of the resistor R_V and trimmer-potentiometer P_V . The value of I_0 according to Eq. (2b) must be obtained with $R_{VM} = R_V + 0.5P_V$. An increase of I_0 with $q\%$ when the potentiometer is short-circuited needs

$$\frac{P_V}{R_V} = 0.02q \left(1 + \frac{1 + R_4/R_3}{R_2/R_{VM}} \right) \quad (12)$$

4. Experimental Results

The circuit was realised with LM357 as OA1 and TDA2030 as OA2. The matrix SM is a simple resistive voltage divider and VM is a resistor 16 k Ω . The resistors $R_1 = R_2 = R_3 = R_4 = 4.99 \text{ k}\Omega/1\%$ and $R_I = 3.966 \Omega$ (measured value) are used too. To prevent possible oscillations a capacitor C is placed in parallel with R_4 . The time constant $R_4 C$ must be approximately 0.5 μs .

The maximal difference between the calculated values of I_0 according to Eq. (2b) and the measured ones is 1.3 %. It was measured $R_0 = 423 \Omega$ and $LR = 8.64 \times 10^{-3}$ (for change of U_C from $\pm 6 \text{ V}$ to $\pm 18 \text{ V}$).

To verify the programming possibility of the circuit the matrix SM was replaced by a simple multiplying DAC (Fig. 2a) with $n_S = 4$, $K_{SM} = m_S/16$ and $R_{SM} = 2 \text{ k}\Omega$. So the Eq. (8c) is transformed to $\Delta I_0 = \frac{U_R}{63.5} \left(2 + \frac{4.99}{R_{VM}[\text{k}\Omega]} \right)$ A. For step change $\Delta I_0 = 50 \text{ mA}$ with $R_{VM} = 16 \text{ k}\Omega$ the reference voltage must be $U_R = 1.372 \text{ V}$. The differences between the calculated and experimentally measured values are not greater than 2 %. A step $\Delta I_0 = 100 \text{ mA}$ with the chosen value of U_R can be obtained by

$$R_{VM} = \frac{4.99}{\frac{63.5\Delta I_0}{U_R} - 2} = 1.90 \text{ k}\Omega. \text{ This value is easily realised with resistor } 2.2 \text{ k}\Omega \text{ in}$$

parallel to $16 \text{ k}\Omega$. The connection is ensured by simple analog switch.

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